

Coulomb drag between a metal and a Wigner crystal.

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We calculated the Coulomb drag contribution to the resistivity and the transresistivity for a double layer system, in which the passive layer is a Wigner crystal pinned by impurities, and the active one is a metal. We found that in quasi one dimensional systems both quantities are suppressed at low temperatures by the constraints of energy and momentum conservation in electron-phonon scattering. In two dimensions both quantities are $\propto T^4$, which is consistent with Bloch law for the contribution of electron-phonon interaction to the resistivity. Strong impurities in the Wigner crystal decrease the transresistivity significantly when their number reaches the logarithm of the number of sites in the crystal. In contrast, the drag contribution to the resistivity is found to be independent of the impurities, at least as long as their density is kept zero in the thermodynamic limit.

I. INTRODUCTION

Coupled quantum wells are useful tools for studying electron-electron interaction in low-dimensional systems both experimentally and theoretically. By changing the distance between the layers, one can allow or prohibit interlayer tunneling and also control the interaction between electrons in different layers. Moreover, by changing parameters such as the density of electrons, the temperature and the magnetic field one can examine different electronic phases.

One effect, which has attracted much attention in recent years, is Coulomb drag¹⁻⁴, where current I_1 in one layer ("the active layer") induces a voltage V_2 in the other ("passive") layer, which is kept in a zero current state ($I_2 = 0$). The measured quantity is the drag resistivity, or trans-resistivity, which for a square sample is defined as $\rho_D \equiv -\frac{V_2}{I_1}$. Since electron-electron collisions have only indirect consequences for transport properties in a single quantum well, because they conserve momentum, the Coulomb drag is unique in directly measuring effects of electron-electron interaction through a transport measurement.

Coulomb drag has been studied extensively in the regime in which carriers in both layers form Fermi liquids. For low enough density the two-dimensional electron liquid should condense into a Wigner crystal¹⁵. A clean Wigner crystal should have no electrical resistivity. However, it is well appreciated by now, from analogous behavior in charge density wave systems⁵, that an arbitrarily small disorder potential should pin the crystal so that there are no charge carriers that can flow in response to an arbitrarily small electric field. The disorder also causes the crystal to deform, so that it has a finite correlation length, or domain size. As a result of pinning, the linear response conductivity vanishes.

In this work we study Coulomb drag in a double layer system in which carriers in the passive layer form a pinned Wigner crystal. The pinning of the crystal is due

to its interaction with strong impurities, whose density is assumed to vanish in the thermodynamic limit. The common methods for calculating drag resistivity are not directly applicable to this case: the Boltzmann equation⁶ can be used to calculate the flow of momentum from the active to the passive layer, but does not distinguish between momentum flow to the electrons in the Wigner crystal and momentum flow to the impurities that pin the crystal. This distinction is important for separating between two different measurable quantities: the contribution of the passive layer to the resistivity of the active layer and the trans-resistivity, proportional to the voltage developing on the passive layer. The Kubo formalism⁷⁻⁹ is useful for calculating the *transconductivity*. However, the inversion of the conductivity matrix, needed to obtain the *transresistivity*, is delicate, due to the vanishing zero temperature conductivity of the passive layer. Thus, this problem necessitates a different method.

To that end, we introduce an harmonic potential of frequency ω_0 , that confines the passive layer and does not allow it to move. When momentum flows from the active to the passive layer, the passive layer is displaced from its equilibrium position. Its displacement, which we call $\mathbf{u}_0$, is determined by the balance between the momentum flux from the active layer and the restoring force exerted by the harmonic confining potential. We calculate $\mathbf{u}_0$, from which we deduce the restoring force and the transresistivity. The introduction of the harmonic potential into the problem allows us to calculate the transresistivity directly by using standard linear response formalism.

II. THE MODEL AND THE PROBLEM

The model is defined as follows. There are two conductors (wires in the quasi- 1D case and layers in the 2D case). Current flows in the active one, which is in a weakly disordered Fermi liquid state. No current flows in

the passive conductor, which is in a Wigner crystal state pinned by impurities.

The Hamiltonian of the system is given by

$$H = H_1 + H_2 + H_{1-2}. \quad (1)$$

Here H_1 and H_2 are the Hamiltonians of the active and passive conductors, and H_{1-2} is the interaction between them.

Thus

$$H_1 = \sum_{\mathbf{p}} \epsilon_{\mathbf{p}} c_{\mathbf{p}}^\dagger c_{\mathbf{p}} + H_{disorder},$$

where $H_{disorder}$ is the standard interaction of electrons in a metal with dilute impurities; the Hamiltonian of the passive conductor, H_2 , describes a crystal interacting with impurities:

$$H_2 = \int \frac{d\mathbf{x}}{s_0} \left(\frac{\mathbf{p}(\mathbf{x})^2}{2m_2} + \frac{1}{2} m_2 v_s^2 (\nabla_i \mathbf{u}_j(\mathbf{x})) (\nabla_i \mathbf{u}_j(\mathbf{x})) + \frac{1}{2} m_2 \omega_0^2 \mathbf{u}(\mathbf{x})^2 - \sum_{imp} \frac{1}{2} A_G G^2 s_0 \mathbf{u}(\mathbf{x})^2 \delta(\mathbf{x} - \mathbf{R}_{imp}) \right), \quad (2)$$

where $\mathbf{u}$ is the displacement field, $\mathbf{p}$ - its conjugate momentum, s_0 is the size of a unit cell of the Wigner crystal, m_2 - the mass of electrons constituting the Wigner

crystal and v_s - the sound velocity of the crystal (for simplicity we assume it to be equal for the longitudinal and transverse modes). G is a basis vector of the reciprocal Wigner lattice, A_G - a parameter, defining the strength of the impurities in the crystal. We expect the induced field (which enters into the definition of trans-resistivity) to be independent of ω_0 , and at the end of the calculation ω_0 is taken to zero. In our analysis of the Hamiltonian (2) we assume that the impurities in the passive layer are dilute and strong, in a sense that is defined below.

The derivation of this Hamiltonian is similar to one given in^{10,11}. We start from a discrete harmonic lattice, interacting with impurities:

$$H_2 = \sum_i \frac{\mathbf{p}(\mathbf{x}_i)^2}{2m_2} + \frac{1}{2} \sum_{i \neq j} \mathbf{u}(\mathbf{x}_i) \mathbf{D}(\mathbf{x}_i - \mathbf{x}_j) \mathbf{u}(\mathbf{x}_j) + \sum_{i, imp} V(\mathbf{x}_i + \mathbf{u}(\mathbf{x}_i) - \mathbf{R}_{imp}). \quad (3)$$

Here $\mathbf{D}$ is the dynamical matrix of the crystal, V - the impurity potential and the third sum extends over lattice and impurity sites. Now we write

$$\mathbf{u} = \mathbf{u}^0 + \mathbf{u}^1,$$

where $\mathbf{u}^0$ gives the static deformation of the crystal due to the impurities, and $\mathbf{u}^1$ - fluctuations around the new equilibrium. Expanding everything in small quantities $\mathbf{u}^1$ to second order, we get:

$$H_2 = \sum_i \frac{\mathbf{p}(\mathbf{x}_i)^2}{2m_2} + \frac{1}{2} \sum_{i \neq j} \mathbf{u}^0(\mathbf{x}_i) \mathbf{D}(\mathbf{x}_i - \mathbf{x}_j) \mathbf{u}^0(\mathbf{x}_j) + \sum_{i, imp} V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp}) + \frac{1}{2} \sum_{i \neq j} \mathbf{u}^1(\mathbf{x}_i) \mathbf{D}(\mathbf{x}_i - \mathbf{x}_j) \mathbf{u}^1(\mathbf{x}_j) + \sum_{i, imp} \frac{1}{2} (\mathbf{u}^1(\mathbf{x}_i) \nabla) (\mathbf{u}^1(\mathbf{x}_i) \nabla) V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp}), \quad (4)$$

where there is no linear in $\mathbf{u}^1$ term, because $\mathbf{u}^0$ minimizes the potential energy, including the impurities, and the crystal is harmonically pinned at each impurity site. We now assume that the impurity strength is much larger than elastic forces in the crystal, so that the lattice adjusts itself in order to minimize the interaction energy with impurities at each impurity site. This is a strong pinning condition¹⁰. It is valid when impurities are strong and dilute. As derived in detail below, the impurities are strong when

$$G^2 A_G \gg 2m_2 v_s \omega_0 / a_0 \quad (5)$$

in quasi 1D, and

$$G^2 A_G \gg \frac{2\pi m_2 v_s^2}{s_0 \ln(\frac{v_s}{a_0 \omega_0})} \quad (6)$$

in 2D. Here a_0 is the lattice spacing.

Assuming strong pinning, $\mathbf{u}^0$ can be found simply by minimizing $\sum_i V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp})$ at each impurity

site. Assuming now that the range of the impurities is much larger than the lattice spacing, but much smaller than the inter-impurity distance, we can write

$$\sum_i V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp}) \approx \sum_i V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{R}_{imp}) - \mathbf{R}_{imp}),$$

which is periodic in $\mathbf{u}^0(\mathbf{R}_{imp})$ with lattice period. Expanding in a Fourier series and taking only the lowest Fourier components, we may approximate

$$\sum_i V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp}) \approx \sum_{\mathbf{G}} A_{\mathbf{G}} \cos(\mathbf{G}(\mathbf{u}^0(\mathbf{R}_{imp}) - \mathbf{R}_{imp})), \quad (7)$$

which for attractive impurities ($A_G < 0$) is minimized when $\cos(\mathbf{G}(\mathbf{u}^0(\mathbf{R}_{imp}) - \mathbf{R}_{imp})) = 1$. Substituting this approximation in the Hamiltonian (4), we get:

$$\sum_{i,imp} \frac{1}{2} (\mathbf{u}^1(\mathbf{x}_i) \nabla) (\mathbf{u}^1(\mathbf{x}_i) \nabla) V(\mathbf{x}_i + \mathbf{u}^0(\mathbf{x}_i) - \mathbf{R}_{imp}) \approx -\frac{1}{2} A_{\mathbf{G}} \sum_{i,imp} (\mathbf{u}^1(\mathbf{x}_i) \mathbf{G}) (\mathbf{u}^1(\mathbf{x}_i) \mathbf{G}) \delta_{\mathbf{x}_i - \mathbf{R}_{imp}}. \quad (8)$$

We now omit the non-dynamical parts of (4) (i.e., the parts that depend only on $\mathbf{u}^0$), add a term $\frac{1}{2} \sum m_2 \omega_0^2 (\mathbf{u}(\mathbf{x}))^2$ to represent a harmonic confining potential for the passive layer, and go to the continuum limit. We obtain the Hamiltonian (2). Since this Hamiltonian does not depend on $\mathbf{u}^0$, we can simplify the notation by omitting the superscript from $\mathbf{u}^1$ and calling it $\mathbf{u}$. It should be remembered, however, that from now on $\mathbf{u}$ is not the deviation of the electron position from a lattice site, but its deviation from the position it holds in equilibrium (which is shifted from the lattice site by the impurities).

The interaction between the conductors is given by

$$H_{1-2} = \left(\delta_{\mathbf{q}+\mathbf{G}} + i \delta_{\mathbf{k}+\mathbf{G}-\mathbf{q}} \mathbf{q} \mathbf{u}_{\mathbf{k}} - \frac{1}{2} \delta_{\mathbf{k}_1+\mathbf{k}_2+\mathbf{G}-\mathbf{q}} (\mathbf{q} \mathbf{u}_{\mathbf{k}_1}) (\mathbf{q} \mathbf{u}_{\mathbf{k}_2}) \right) n_2 U_{\mathbf{q}} c_{\mathbf{p}+\mathbf{q}}^\dagger c_{\mathbf{p}}, \quad (9)$$

where n_2 is the density of lattice sites in the Wigner crystal. This is just the inter-layer Coulomb interaction expanded to second order in terms of the crystal displacement field. We omitted here a term arising from the static deformation of the Wigner crystal due to impurities. $U_{\mathbf{q}}$ is the Fourier component of the screened interlayer Coulomb potential. We take it to be constant at wave length smaller than the interlayer spacing, while at larger wavelengths it decreases exponentially.

The problem is posed as follows: given a current density $\mathbf{j}_1$ in the active conductor and $\mathbf{j}_2 = 0$ in the passive conductor, what are the electric fields $\mathbf{E}_1 + \delta \mathbf{E}_1$ and $\mathbf{E}_2$ in the conductors? (Here $\mathbf{E}_1$ is the field which would be in the active conductor in the absence of the passive one). Using the resistivity matrix⁷, we can write this as

$$\begin{pmatrix} \mathbf{E}_1 + \delta \mathbf{E}_1 \\ \mathbf{E}_2 \end{pmatrix} = \begin{pmatrix} \rho + \delta \rho & -\rho_D \\ -\rho_D & \rho_W \end{pmatrix} \begin{pmatrix} \mathbf{j}_1 \\ 0 \end{pmatrix}, \quad (10)$$

where ρ is the resistivity of the active layer in the absence of drag. What we need to find are $\delta \rho$ and ρ_D .

We find the field E_2 by calculating u_0 , since the two are related by

$$E_2 = \frac{m_2 \omega_0^2 u_0}{e}, \quad (11)$$

while $\delta \mathbf{E}_1$ is found by calculating $\delta \mathbf{j}_1$ – the negative contribution to the current in the active conductor at a given field E_1 due to the drag. Then, for weak drag,

$$\delta \mathbf{j}_1 \equiv -\delta \mathbf{E}_1 / \rho. \quad (12)$$

We consider both quasi 1D coupled conductors (by which we mean wires of several conduction channels, in which electrons form either a Fermi liquid or a Wigner crystal), and two dimensional conductors. We focus mostly on the latter.

III. RESULTS

In quasi 1D conductors the transresistivity and the drag contribution to the resistivity are suppressed at low temperatures in the limit of vanishing ω_0 and infinite L , since in that limit momentum and energy cannot be conserved simultaneously for electron-phonon scattering.

In the 2D case the transresistivity is found to be

$$\rho_D = Z \frac{m_1}{m_2} \frac{U_0^2 T^4}{e^2 \hbar^5 v_{fs} v_s^5 n_1} \left(1 - \frac{N_{imp}}{2\pi \ln(L/a_0)} \right), \quad (13)$$

where U_0 is the zero wave vector component of the inter-layer interaction, Z - a numerical factor given by

$$Z = \frac{2}{\pi^2} \int_0^\infty \frac{z^4 dz}{\sinh^2(z)},$$

m_1 is the electron mass in the active (metallic) layer, m_2 is the electron mass in the Wigner crystal, v_s is the sound velocity in the Wigner crystal, $v_{fs} \equiv \sqrt{v_f^2 - v_s^2}$, with v_f being the Fermi velocity in the metallic layer (we assume $v_f > v_s$ and that v_f , v_s and v_{fs} are of the same order of magnitude); n_1 is the density of electrons, N_{imp} is the number of impurities, and L/a_0 - the ratio between the size of the system and that of a unit cell. The impurities are supposed to be dilute enough, so that a condition $N_{imp} \ll \ln(L/a_0)$ is satisfied.

We see that impurities in the passive conductor decrease the transresistivity. Due to the force they exert on the crystal, part of the momentum flux from the active layer is transferred to the impurities. This part does not lead to drag. Stretching the approximation to its limit, we find that the influence of the impurities becomes significant once their number reaches the logarithm of the number of electrons in the Wigner crystal. The impurity strength does not appear in the final expression as long as it is much larger than elastic forces in the Wigner crystal. The temperature dependence is consistent with the 2D extension of the Bloch law for the resistance due to electron-phonon scattering.

The drag contribution to the resistivity in 2D is, in the limit of dilute impurities,

$$\begin{aligned} \delta \rho &= \frac{n_2}{n_1} \rho_D \left(1 - \frac{N_{imp}}{2\pi \ln(L/a_0)} \right)^{-1} \\ &= Z \frac{n_2 m_1}{n_1 m_2} \frac{U_0^2 T^4}{e^2 \hbar^5 v_{fs} v_s^5 n_1}. \end{aligned} \quad (14)$$

This contribution is not suppressed by the impurity induced factor $\left(1 - \frac{N_{imp}}{2\pi \ln(L/a_0)} \right)$. The momentum, that

flows to the impurities, does increase the resistivity in the active layer, although it does not induce voltage on the electrons in the passive layer. In the absence of impurities, the ratio between the transresistivity and the drag contribution to the resistivity is n_1/n_2 , as required by the Galilean invariance. Due to this invariance the two electronic systems can flow at equal speeds without any friction resulting from their interaction. Thus when $j_1/j_2 = n_1/n_2$ we must have

$$\delta E = j_1 \delta \rho - j_2 \rho_D = 0. \quad (15)$$

IV. CALCULATION

As explained in the introduction, the calculation is done using the linear response formalism. We first consider the trans-resistivity of the passive conductor and then the contribution of inter-layer interaction to the resistance of the active conductor.

A. The transresistivity

From the Kubo formula we find the displacement of the Wigner crystal:

$$\langle \mathbf{u}_0^\alpha \rangle = \lim_{\omega \rightarrow 0} \frac{1}{\omega \hbar} \int_0^\infty dt \exp^{i\omega t} \langle [\mathbf{u}_0^\alpha(t), \mathbf{j}_0^\beta] \rangle \mathbf{E}_1^\beta, \quad (16)$$

where $\mathbf{j}_0 = e/m \sum_{\mathbf{q}} \mathbf{q} c_{\mathbf{q}}^\dagger c_{\mathbf{q}}$ is the current operator for the active layer and $\mathbf{E}$ - the applied electric field (in the same layer). Proceeding as usual^{13,14}, we define the correlator Π_u by

$$\langle \mathbf{u}_0(\omega) \rangle = \frac{i}{\omega} \Pi_u(\omega) \frac{e}{m_1} \mathbf{E}, \quad (17)$$

where we have assumed isotropy. Then in imaginary time the correlator is given by

$$\Pi_u(i\omega) = \int_0^\beta \tau e^{i\omega\tau} \langle T \mathbf{u}_0(\tau) \mathbf{p}_0^E \rangle. \quad (18)$$

Here β is the inverse temperature and $\mathbf{p}_0^E$ is the component of the total momentum of electrons in the active conductor in the direction of the applied field. This correlator is then calculated to lowest order of inter-layer interaction. The corresponding diagrams are shown in Fig. 1. Note that the last pair of diagrams vanishes, since the transferred momentum is zero.

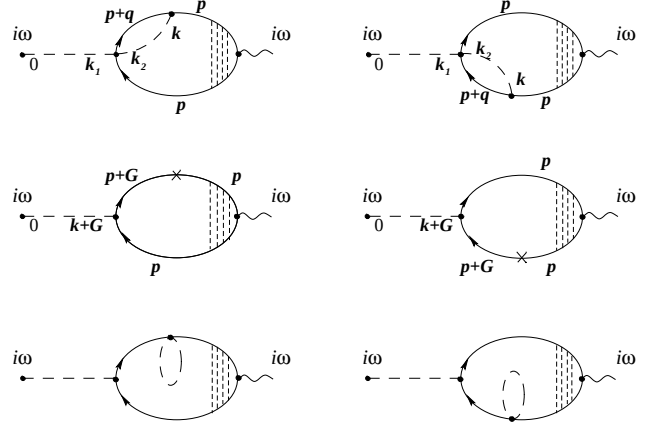


FIG. 1. Diagrams contributing to the drag coefficient to second order in the electron-phonon potential. The full lines are electron Green's functions, the long dashed lines are phonon Green's functions, the short dashed ladder represents a diffuson, and the wavy line is a current vertex. The cross represents a periodic external potential.

Calculation of the topmost pair of diagrams yields an expression for Π_u :

$$\Pi_u(\omega \rightarrow 0) = \sum_{\mathbf{k}_1 \mathbf{k}_2 \mathbf{p}} -2i \left(\frac{\hbar}{2m_2} \right)^2 \frac{\mathbf{q}^2 \mathbf{q}_x}{\sqrt{\omega_0 \omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2} \omega_{\mathbf{k}}}} D_{\mathbf{k}_1 0}(0) \left(\frac{U_{\mathbf{q}}}{S} \right)^2 \int \frac{d\epsilon_1}{2\pi i} \int \frac{d\epsilon_2}{2\pi i} \hbar \omega \Gamma_{\mathbf{p}}^x |G_{\mathbf{p}}(\epsilon_1)|^2 \beta n_F(\epsilon_1) n_F(-\epsilon_1 - \epsilon_2) n_B(\epsilon_2) (D_{\mathbf{k}_2 \mathbf{k}}(\epsilon_2) - D_{\mathbf{k} \mathbf{k}_2}^*(\epsilon_2)) \Im G_{\mathbf{p}+\mathbf{q}}(\epsilon_1 + \epsilon_2), \quad (19)$$

where in the neglect of Umklapp processes $\mathbf{q} = \mathbf{k} = \mathbf{k}_1 + \mathbf{k}_2$ and $\mathbf{k}_1, \mathbf{k}_2, \mathbf{k}$ are in the Brillouin zone. The frequency $\omega_{\mathbf{k}} = \sqrt{v_s^2 \mathbf{k}^2 + \omega_0^2}$ is the phonon frequency for a clean crystal, S is the area of the sample, Γ is an electron current vertex function in the active layer, G is the conventional electron propagator in the active layer, and finally D is the phonon propagator including impurities, which should be calculated. Substituting for G , which gives delta-functions, integrating over ϵ_1 and ϵ_2 , and assuming no Umklapp (since the potential $U_{\mathbf{q}}$ is suppressed at large $\mathbf{q}$), so that $\mathbf{q} = \mathbf{k}$, we get

$$\Pi_u(\omega \rightarrow 0) = \sum_{\mathbf{k}_1 \mathbf{k}_2 \mathbf{p}} D_{\mathbf{k}_1 0}(0) \left(\frac{\hbar}{2m_2} \right)^2 \frac{\mathbf{k}^2 \mathbf{k}_x U_{\mathbf{k}}^2}{S^2 \sqrt{\omega_0 \omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2} \omega_{\mathbf{k}}}} \omega \beta n_F(\epsilon_{\mathbf{p}}) n_F(-\epsilon_{\mathbf{p}+\mathbf{k}}) \times n_B(\epsilon_{\mathbf{p}+\mathbf{k}} - \epsilon_{\mathbf{p}}) \tau_i \hbar \mathbf{p}_x (D_{\mathbf{k}_2 \mathbf{k}}((\epsilon_{\mathbf{p}+\mathbf{k}} - \epsilon_{\mathbf{p}})/\hbar) - D_{\mathbf{k} \mathbf{k}_2}^*((\epsilon_{\mathbf{p}+\mathbf{k}} - \epsilon_{\mathbf{p}})/\hbar)), \quad (20)$$

where τ_t is the electron transport scattering time for the active conductor and ϵ_p - electron energy for the active conductor. Now we sum over $\mathbf{p}$, assuming $T \ll \epsilon_F$ and $1/d \ll k_f$ (where d is the spacing between the conductors and k_f the Fermi wave vector). Then

$$\begin{aligned} \Pi_u(\omega \rightarrow 0) = & \sum_{\mathbf{k}_1 \mathbf{k}_2} -\frac{1}{2} N(0) D_{\mathbf{k}_1 0}(0) \left(\frac{\hbar}{2m_2} \right)^2 \hbar \omega \beta \\ & \times \frac{\mathbf{k}^2 \mathbf{k}_x^2 U_{\mathbf{k}}^2}{S^2 \sqrt{\omega_0 \omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2} \omega_{\mathbf{k}}}} \frac{\hbar v_F k \cos \theta}{4 \sinh^2(\beta \hbar v_F k \cos \theta / 2)} (D_{\mathbf{k} 2 \mathbf{k}}(v_F k \cos \theta) - D_{\mathbf{k} \mathbf{k} 2}^*(v_F k \cos \theta)), \end{aligned} \quad (21)$$

where $N(0)$ is the extensive density of states for the metallic conductor. To proceed further, we have to calculate the phonon propagator D in the presence of impurities. Here we calculate the phonon propagator in different dimensions, assuming that strength of the impurities is much larger than typical elastic forces in the crystal, i.e., strong pinning. To formulate quantitatively this condition, we consider the static deformation of the Wigner lattice due to all impurities. In our derivation of H_2 above, we assumed that the fragment of the lattice, that interacts with each impurity, is positioned in a way, that minimizes this interaction. In doing so, we neglected elastic forces on the scale of inter-impurity distance and found out that, up to a lattice constant, the displacement of a fragment interacting with an impurity at $\mathbf{R}_{imp}$ satisfies $\mathbf{u}^0 = \mathbf{R}_{imp}$. The elastic forces between fragments will modify this displacement. We now express this modification in terms of phonon propagator. In coordinate representation the propagator is

$$\tilde{D}(\omega, \mathbf{x}_1, \mathbf{x}_2) \equiv \int \frac{dt}{\hbar} e^{i\omega t} (-i\theta(t) \langle [u_{\mathbf{x}_1}(t), u_{\mathbf{x}_2}(0)] \rangle), \quad (22)$$

and it can be written in momentum representation as:

$$\tilde{D}(\omega, \mathbf{x}_1, \mathbf{x}_2) = \sum_{\mathbf{k}_1, \mathbf{k}_2} \frac{\hbar D_{\mathbf{k}_1, \mathbf{k}_2}(\omega) e^{i\mathbf{k}_1 \mathbf{x}_1 - i\mathbf{k}_2 \mathbf{x}_2}}{2N_2 m_2 \sqrt{\omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2}}}, \quad (23)$$

where N_2 is the number of sites in the Wigner lattice. The propagator $\tilde{D}$ relates a point force f applied at $\mathbf{x}_2$ to the displacement $u_{\mathbf{x}_1}$ it generates at $\mathbf{x}_1$

$$u_{\mathbf{x}_1} = -\tilde{D}(\omega = 0, \mathbf{x}_1, \mathbf{x}_2) f. \quad (24)$$

The force exerted on the lattice by an impurity at $\mathbf{R}_i$ is (assuming $\mathbf{G}(\mathbf{u}^0(\mathbf{R}_i) - \mathbf{R}_i) \ll 1$)

$$G^2 A_G (\mathbf{R}_i - \mathbf{u}_{\mathbf{x}_i}^0).$$

Consequently, the displacement $\mathbf{u}_{\mathbf{x}_k}^0$ satisfies the equation

$$\mathbf{u}_{\mathbf{x}_k}^0 = - \sum_i \tilde{D}^f(\omega = 0, \mathbf{x}_k, \mathbf{x}_i) G^2 A_G (\mathbf{R}_i - \mathbf{u}_{\mathbf{x}_i}^0), \quad (25)$$

where $\tilde{D}^f(\omega = 0, \mathbf{x}_1, \mathbf{x}_2)$ is the propagator of a clean crystal in the coordinate representation. When the impurities are dilute, $-\tilde{D}^f(\omega = 0, \mathbf{x}_k, \mathbf{x}_k) \gg -\tilde{D}^f(\omega = 0, \mathbf{x}_k, \mathbf{x}_i)$ for $i \neq k$. Under this condition we may retain only the

term with $i = k$ in the sum, and the strong pinning condition, requiring that $u^0 \gg r_{imp} - u^0$ becomes:

$$-\tilde{D}^f(\omega = 0, \mathbf{x}_k, \mathbf{x}_k) G^2 A_G \gg 1. \quad (26)$$

Physically, the neglect of the $i \neq k$ terms in the sum (25) implies that the local displacement $u_{\mathbf{x}_k}^0$ is determined by a balance between the potential exerted by the closest impurity and the confining harmonic potential characterized by ω_0 .

In 1D the condition (26) is

$$G^2 A_G \gg 2m_2 v_s \omega_0 / a_0, \quad (27)$$

while in 2D:

$$G^2 A_G \gg \frac{2\pi m_2 v_s^2}{s_0 \ln(\frac{v_s}{a_0 \omega_0})}, \quad (28)$$

where s_0 is the area of the unit cell.

The calculation of the phonon propagator in the presence of the impurities goes as follows. We start from a differential equation satisfied by the propagator in the coordinate representation:

$$\begin{aligned} \left(\omega^2 + v_s^2 \nabla^2 - \omega_0^2 + \sum_i \frac{s_0 G^2 A_G}{m_2} \delta(\mathbf{x} - \mathbf{x}_i) \right) \tilde{D}(\omega, \mathbf{x}, \mathbf{x}') \\ = \frac{s_0 \delta(\mathbf{x} - \mathbf{x}')}{m_2}, \end{aligned} \quad (29)$$

where the sum is over the impurities. This equation can be solved in terms of the free propagator

$$\begin{aligned} \tilde{D}(\omega, \mathbf{x}, \mathbf{x}') = \tilde{D}^f(\omega, \mathbf{x} - \mathbf{x}') - \\ \sum_i G^2 A_G \tilde{D}^f(\omega, \mathbf{x} - \mathbf{x}_i) \tilde{D}(\omega, \mathbf{x}_i, \mathbf{x}'), \end{aligned} \quad (30)$$

which gives

$$\tilde{D}(\omega, \mathbf{x}_k, \mathbf{x}') = \sum_j (\mathcal{A}^{-1})_{kj} \tilde{D}^f(\omega, \mathbf{x}_j - \mathbf{x}'), \quad (31)$$

with matrix $\mathcal{A}$ defined by

$$\mathcal{A}_{ji} = \delta_{ji} + G^2 A_G \tilde{D}^f(\omega, \mathbf{x}_j - \mathbf{x}_i). \quad (32)$$

Substituting this back into (30), we obtain

$$\tilde{D}(\omega, \mathbf{x}, \mathbf{x}') = \tilde{D}^f(\omega, \mathbf{x}, \mathbf{x}') - \sum_{ij} G^2 A_G \tilde{D}^f(\omega, \mathbf{x} - \mathbf{x}_i) (\mathcal{A}^{-1})_{ij} \tilde{D}^f(\omega, \mathbf{x}_j - \mathbf{x}'). \quad (33)$$

Using (23), we can obtain an expression for the propagator in the momentum representation:

$$\begin{aligned} D_{\mathbf{k}_1 \mathbf{k}_2}(\omega) &= D_{\mathbf{k}_1}^f(\omega) \delta_{\mathbf{k}_1 \mathbf{k}_2} - \sum_{ij} \frac{\hbar}{2N_2 m_2} G^2 A_G (\mathcal{A}^{-1})_{ij} D_{\mathbf{k}_1}^f(\omega) D_{\mathbf{k}_2}^f(\omega) e^{-i\mathbf{k}_1 \mathbf{x}_i + i\mathbf{k}_2 \mathbf{x}_j} \\ &= \frac{2\omega_{\mathbf{k}_1} \delta_{\mathbf{k}_1 \mathbf{k}_2}}{\hbar((\omega + i\delta)^2 - \omega_{\mathbf{k}_1}^2)} - \sum_{i,j} \frac{2\sqrt{\omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2}} G^2 A_G (\mathcal{A}^{-1})_{ij}}{\hbar m_2 N_2} \frac{e^{-i\mathbf{k}_1 \mathbf{x}_i} e^{i\mathbf{k}_2 \mathbf{x}_j}}{((\omega + i\delta)^2 - \omega_{\mathbf{k}_1}^2)((\omega + i\delta)^2 - \omega_{\mathbf{k}_2}^2)}, \end{aligned} \quad (34)$$

where the free propagator in the momentum representation was used:

$$D_{\mathbf{k}_1 \mathbf{k}_2}^f(\omega) = \delta_{\mathbf{k}_1 \mathbf{k}_2} D_{\mathbf{k}_1}^f(\omega) = \frac{2\omega_{\mathbf{k}_1}}{\hbar((\omega + i\delta)^2 - \omega_{\mathbf{k}_1}^2)}. \quad (35)$$

In the limit of strong pinning, the propagator satisfies an important relationship:

$$\sum_{\mathbf{k}} \frac{e^{i\mathbf{k}_1 \mathbf{x}_l} D_{\mathbf{k}_1 0}(\omega = 0)}{\sqrt{\omega_0 \omega_{\mathbf{k}_1}}} \propto \mathcal{O}\left(\frac{1}{G^2 A_G \tilde{D}^f(\omega = 0, \mathbf{x} = 0)}\right) \approx 0, \quad (36)$$

where $\mathbf{x}_l$ is an impurity site. This relationship means that a force, when applied at an impurity site, causes a much smaller deformation, than when applied anywhere else, since it is opposed by the impurity. The proof of this relationship follows from the equation satisfied by the propagator $\tilde{D}$, namely $\tilde{D} = \mathcal{A}^{-1} \tilde{D}^f$. In the strong pinning limit $\mathcal{A}_{ij} \approx G^2 A_G \tilde{D}^f(\omega, \mathbf{x}_j - \mathbf{x}_i)$ and hence (36).

From the above relationship it follows that for all $\Omega \gg \omega_0$,

$$\sum_{\mathbf{k}_1} \frac{D_{\mathbf{k}_1 0}(0)(D_{\mathbf{k}_2 \mathbf{k}}^i(\Omega) - (D_{\mathbf{k} \mathbf{k}_2}^i(\Omega))^*)}{\sqrt{\omega_0 \omega_{\mathbf{k}_1}}} \approx 0, \quad (37)$$

where $D^i \equiv D - D_f$ is a part of the propagator due to the impurities. To see this, we note using Eq. (34) that $D_{\mathbf{k}_1 0}(0)/\sqrt{\omega_{\mathbf{k}_1}}$ is a sharply peaked function of $\mathbf{k}_1$ around $\mathbf{k}_1 = 0$: its free part is proportional to $\delta_{\mathbf{k}_1, 0}$, and the part due to impurities is peaked around zero with width ω_0/v_s , because of the denominator $1/\omega_{\mathbf{k}_1}^{3/2}$. In contrast, $D_{\mathbf{k}_2 \mathbf{k}}^i(\Omega)$ varies slowly in that region, except for the exponential factor $e^{-i\mathbf{k}_2 \mathbf{x}_i} = e^{-i\mathbf{k} \mathbf{x}_i} e^{i\mathbf{k}_1 \mathbf{x}_i}$. Hence the summation is actually of the form (36).

Using the last relationship in (21), and taking into account that the typical energy transfer in an inter-layer scattering event, $v_F k \cos \theta$, is of the order of the temperature, and thus much larger than ω_0 , we see that the effect of impurities enters Eq. (21) only in the first phonon propagator, where the frequency is zero, while for the second phonon propagator, that carries a non-zero frequency, only the free part of D contributes. Thus,

$$\begin{aligned} \Pi_u &= -N(0) \sum_{\mathbf{k}_1 \mathbf{k}} D_{\mathbf{k}_1 0}^R(0) \left(\frac{\hbar}{2m_2}\right)^2 \frac{k^2 U_{\mathbf{k}}^2}{S^2 \sqrt{\omega_0 \omega_{\mathbf{k}_1} \omega_{\mathbf{k}_2} \omega_{\mathbf{k}}}} \\ &\quad \times \hbar \omega \beta \tau_t \mathbf{k}_x^2 \frac{v_f \hbar k \cos \theta}{4 \sinh^2(\beta v_f \hbar k \cos \theta / 2)} \\ &\quad \times \left(\sum_{\mp} \mp \frac{\delta_{\mathbf{k}_2 \mathbf{k}}}{\hbar} \delta(v_f k \cos \theta \mp \omega_k) \right). \end{aligned} \quad (38)$$

To proceed further with the calculation, we should consider different dimensions. In 1D (where electrons in the active wire are in the Fermi liquid regime) $\cos \theta = \pm 1$, so that the momentum conservation condition is never satisfied (in the limit of vanishing ω_0 and vanishing temperature). This prevents the crystal from getting any momentum from the conductor and thus the trans-resistivity is zero in the low temperature limit.

The situation is different in two dimensions. In order to calculate Π_u in 2D we have first to find $D_{00}(0)$. For this we write approximately eq.(32) for $\omega = 0$:

$$\mathcal{A}_{ji}(\omega = 0) = G^2 A_G \tilde{D}^f(\omega = 0, \mathbf{x}_j - \mathbf{x}_i). \quad (39)$$

Now we assume that the number of impurities is so low that the distance between them is of the order of the system size (hereby neglecting fluctuations in which impurities could be close together). Then the matrix $\mathcal{A}$ satisfies

$$\mathcal{A}_{ij}(\omega = 0) \ll \mathcal{A}_{ii}(\omega = 0) \quad (40)$$

for $i \neq j$. The matrix A then can be inverted approximately:

$$\begin{aligned} \mathcal{A}_{ij}^{-1}(\omega = 0) &\approx S(i, j) \frac{1}{G^2 A_G (\tilde{D}^f(\omega = 0, \mathbf{x} = 0))^2} \\ &\quad \times \tilde{D}^f(\omega = 0, \mathbf{x}_j - \mathbf{x}_i), \end{aligned} \quad (41)$$

where $S(i, j) = 1$ for $i = j$ and -1 for $i \neq j$. Substituting this into (30), we find $D_{00}(0)$ in 2D:

$$D_{00}(0) = -\frac{2}{\hbar\omega_0} + \frac{4\pi v_s^2 N_{imp}}{\hbar L^2 \omega_0^3 \ln(\frac{v_s}{a_0\omega_0})}, \quad (42)$$

where N_{imp} is the number of impurities. The $\ln(\frac{v_s}{a_0\omega_0})$ originates from the expression for $\tilde{D}_f(\omega = 0, \mathbf{x}_1 = 0, \mathbf{x}_2 = 0)$ in 2D.

Substituting expression (42) for the propagator into Eq.(38) and choosing

$$\omega_0 \sim \frac{v_s}{L},$$

we obtain the transresistivity Eq. (13).

As evident in Eq. (13), the impurities decrease the trans-resistivity as they absorb part of the momentum transferred from the active layer. That part of the transferred momentum does not generate a drag voltage, and therefore does not lead to trans-resistivity. Under the strong pinning approximation, the influence of the impurities becomes significant when their number is comparable to $\ln(L/a_0)$, even though their density is still zero in the thermodynamic limit.

B. Drag contribution to resistivity

We now turn to the way electron-electron scattering between different layers affects the resistivity of the active layer. We again apply the Kubo formula to find, to second order in screened inter-layer interaction, the current density in the active layer as a response to an electric

field in that same layer (we expect it to be negative as the drag should decrease the current):

$$\mathbf{j}^\alpha = \text{Re} \frac{1}{\hbar\omega S} \int_0^\infty dt e^{i\omega t} \langle [\mathbf{j}_0^\alpha(t), \mathbf{j}_0^\beta] \rangle \mathbf{E}^\beta. \quad (43)$$

Introducing the correlator from

$$\mathbf{j}^\alpha = \frac{i}{\omega} \lim_{\omega \rightarrow 0} \Im \Pi_j^{\alpha\beta}(\omega) \mathbf{E}^\beta, \quad (44)$$

we have in imaginary time:

$$\Pi(i\omega) = -\frac{1}{S} \int_0^\beta d\tau e^{i\omega\tau} \langle T \mathbf{j}_0^x(\tau) \mathbf{j}_0^x(0) \rangle, \quad (45)$$

where we again assumed isotropy. The corresponding diagrams are shown in Fig. 2.

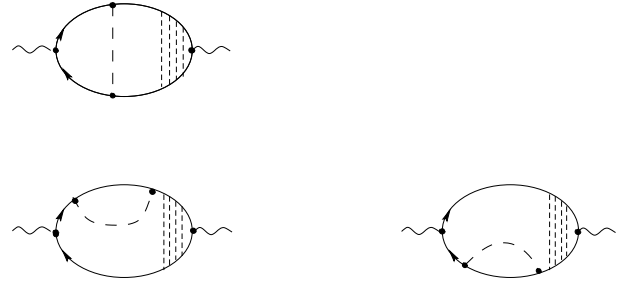


FIG. 2. Diagrams contributing to reduction of conductivity of the active conductor

Calculating them, we obtain

$$\Pi = -\left(\frac{e}{m_1}\right)^2 \sum_{\mathbf{p}, \mathbf{k}} k^2 \left(\frac{U_k}{S}\right)^2 n_2 \frac{\hbar}{2m_2\omega_k} \omega\beta \frac{n_F(\epsilon_{\mathbf{p}}) - n_F(-\epsilon_{\mathbf{p}+\mathbf{k}})}{4 \sinh^2(\beta(\epsilon_{\mathbf{p}+\mathbf{k}} - \epsilon_{\mathbf{p}})/2)} \Im D_{\mathbf{k}\mathbf{k}}^R(\epsilon_{\mathbf{p}+\mathbf{k}} - \epsilon_{\mathbf{p}}) \hbar\tau_t^2 \mathbf{k}_{\mathbf{x}}^2. \quad (46)$$

In one dimension, when the passive layer is clean, the constraints of energy and momentum conservation together with the Pauli principle suppress the resistivity at low temperature. In the presence of impurities in the Wigner crystal momentum conservation is relaxed, and we obtain a contribution, which is inversely proportional to the length of the system. This contribution can be neglected, since in the macroscopic limit we assume the length to go to infinity, while the density of impurities is kept zero.

In two dimensions, in the absence of impurities momentum and energy can be conserved simultaneously, and inter-layer interaction yields the following contribution to the current

$$\delta \mathbf{j}_1 = -\frac{e^2 n_2 U_0^2 T^4 \tau_t^2}{\hbar^5 m_1 m_2 v_{fs} v_s^5} Z \mathbf{E}_1 \equiv \delta \sigma \mathbf{E}_1, \quad (47)$$

from which the drag contribution to the resistivity is easily found:

$$\delta \rho = -\rho^2 \delta \sigma = \frac{n_2 U_0^2 T^4 m_1}{e^2 \hbar^5 m_2 v_{fs} v_s^5 n_1^2} Z. \quad (48)$$

In the presence of impurities the phonon propagator is composed of a free part and an impurity-induced part. The contribution of the former remains Eq. (48), while the contribution of the latter is again inversely proportional to the system size. Hence in the macroscopic limit the impurities do not affect Eq. (48).

When the passive layer is clean, the ratio between the trans-resistivity and the drag contribution to resistivity of the active layer is n_1/n_2 . This is consistent with the Galilean invariance requirement.

V. SUMMARY

We considered a bi-layer system in which the passive layer is a Wigner crystal pinned by impurities and the active layer is a conductor, and calculated the transresistivity between two layers and the drag contribution to the resistivity of the active layer. We focused on the case of a small number of strong impurities, whose density vanishes in the thermodynamic limit. We found that in quasi 1D case both quantities are exponentially small at low temperature due to constraints of energy and momentum conservation.

In two dimensions we found a T^4 -dependence of both quantities, consistent with the Bloch law for the electron-phonon interaction contribution to resistivity. Impurities in the Wigner crystal decrease the transresistivity significantly when their number reaches the logarithm of the number of sites in the crystal. In the limit of strong pinning the transresistivity and the active layer resistivity are independent of the impurity strength.

While a minute density of impurities is sufficient to affect the transresistivity, we find that it does not significantly affect the contribution of the Wigner crystal to the resistivity of the active layer.

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